Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r .
10/801,933	AOYAGI, AKIYOSHI	
Examiner	Art Unit	
Ben P. Sandvik	2826	

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated EAST search	9/18/2006	BPS	